

TOSHIBA TRANSISTOR SILICON NPN TRIPLE DIFFUSED TYPE

## 2SC5459

SWITCHING REGULATOR APPLICATIONS

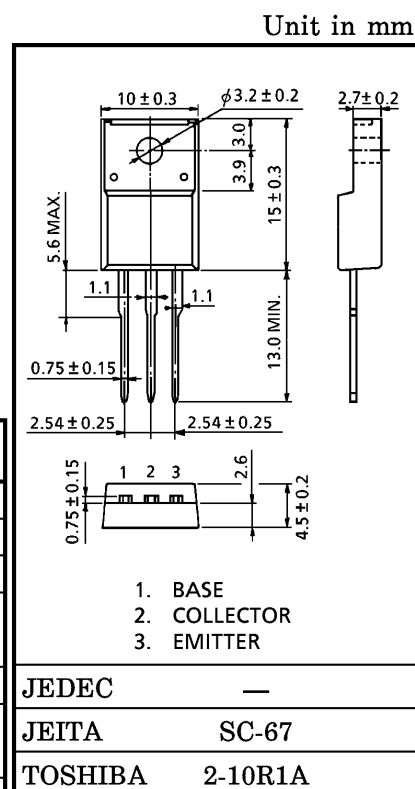
HIGH VOLTAGE SWITCHING APPLICATIONS

DC-DC CONVERTER APPLICATIONS

- High Speed Switching :  $t_f = 0.3 \mu s$  (Max.) ( $I_C = 1.2 A$ )
- High Collector Breakdown Voltage :  $V_{CEO} = 400 V$
- High DC Current Gain :  $h_{FE} = 20$  (Min.) ( $I_C = 0.3 A$ )

MAXIMUM RATINGS ( $T_c = 25^\circ C$ )

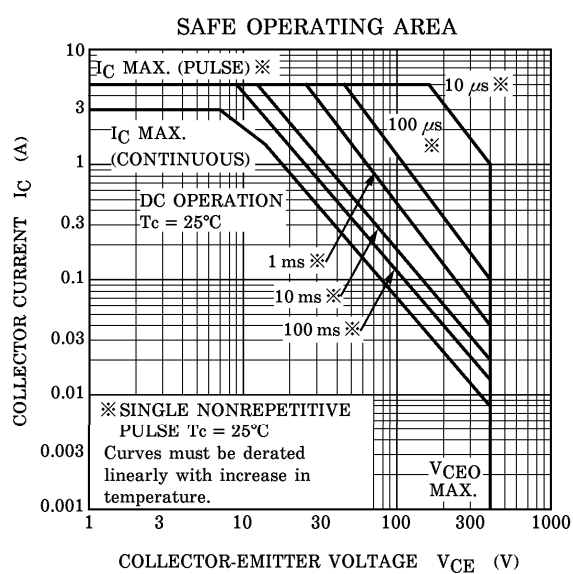
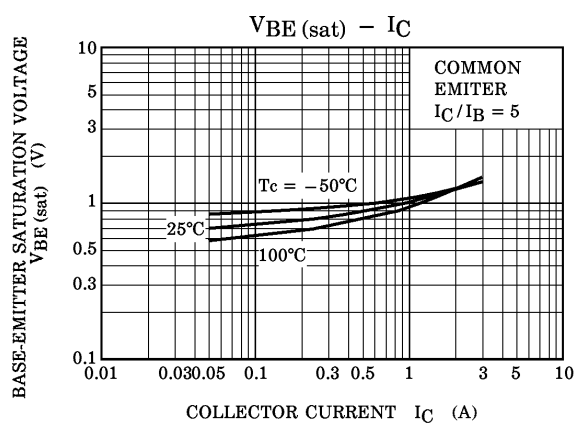
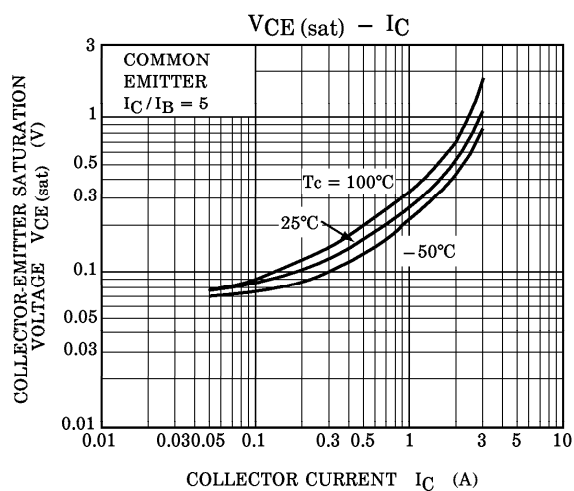
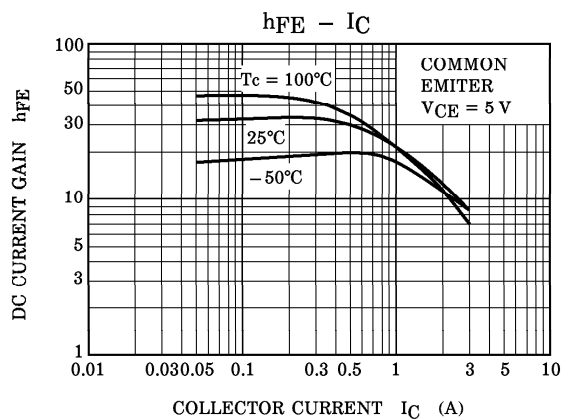
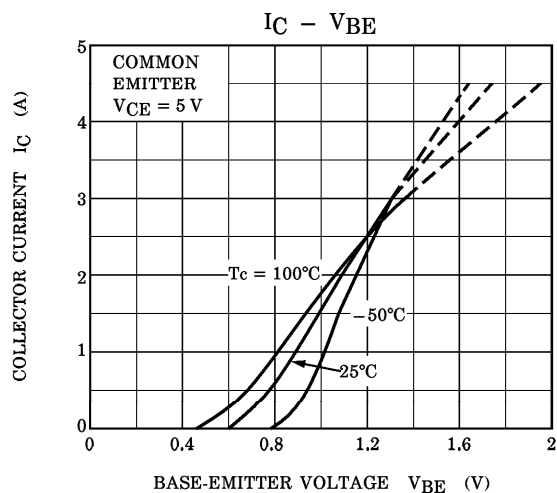
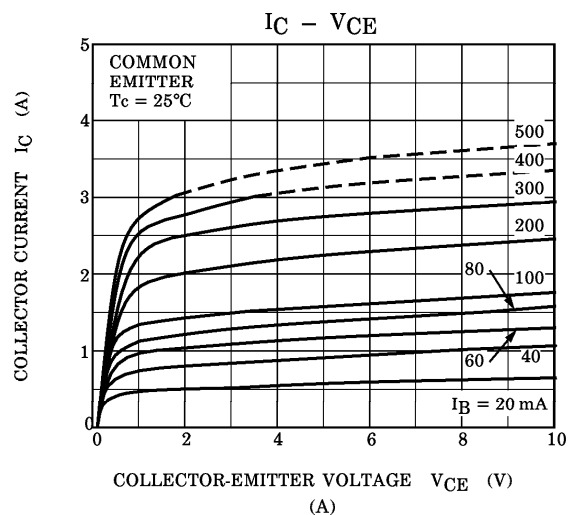
CHARACTERISTIC		SYMBOL	RATING	UNIT
Collector-Base Voltage		$V_{CBO}$	600	V
Collector-Emitter Voltage		$V_{CEO}$	400	V
Emitter-Base Voltage		$V_{EBO}$	7	V
Collector Current	DC	$I_C$	3	A
	Pulse	$I_{CP}$	5	
Base Current		$I_B$	1	A
Collector Power Dissipation	$T_a = 25^\circ C$	$P_C$	2.0	W
	$T_c = 25^\circ C$		25	
Junction Temperature		$T_j$	150	$^\circ C$
Storage Temperature Range		$T_{stg}$	$-55 \sim 150$	$^\circ C$



Weight : 1.7 g (Typ.)

ELECTRICAL CHARACTERISTICS ( $T_c = 25^\circ C$ )

CHARACTERISTIC		SYMBOL	TEST CONDITION	MIN.	TYP.	MAX.	UNIT
Collector Cut-off Current		$I_{CBO}$	$V_{CB} = 480 V, I_E = 0$	—	—	100	$\mu A$
Emitter Cut-off Current		$I_{EBO}$	$V_{EB} = 7 V, I_C = 0$	—	—	10	$\mu A$
Collector-Base Breakdown Voltage		$V_{(BR) CBO}$	$I_C = 1 mA, I_B = 0$	600	—	—	V
Collector-Emitter Breakdown Voltage		$V_{(BR) CEO}$	$I_C = 10 mA, I_B = 0$	400	—	—	V
DC Current Gain	$h_{FE} (1)$		$V_{CE} = 5 V, I_C = 1 mA$	13	—	—	
	$h_{FE} (2)$		$V_{CE} = 5 V, I_C = 0.3 A$	20	—	—	
Collector-Emitter Saturation Voltage		$V_{CE (sat)}$	$I_C = 1.2 A, I_B = 0.15 A$	—	—	1.0	V
Base-Emitter Saturation Voltage		$V_{BE (sat)}$	$I_C = 1.2 A, I_B = 0.15 A$	—	—	1.3	V
Switching Time	Turn-on Time	$t_r$		—	—	0.5	$\mu s$
	Storage Time	$t_{stg}$		—	—	2.0	
	Fall Time	$t_f$		—	—	0.3	



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